

## AO4812A



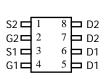


# **General Description**

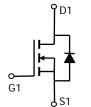
The AO4812A uses advanced trench technology to provide excellent  $R_{\rm DS(ON)}$  and low gate charge. The two MOSFETs make a compact and efficient switch and synchronous rectifier combination for use in buck converters. AO4812A is Pb-free (meets ROHS & Sony 259 specifications). AO4812AL is a Green Product ordering option. AO4812A and AO4812AL are electrically identical.

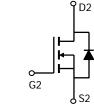
### **Features**

$$\begin{split} &V_{DS} \; (V) = 30V \\ &I_{D} = 6.9A \; (V_{GS} = 10V) \\ &R_{DS(ON)} < 28m\Omega \; (V_{GS} = 10V) \\ &R_{DS(ON)} < 42m\Omega \; (V_{GS} = 4.5V) \end{split}$$









Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		$V_{DS}$	30	V			
Gate-Source Voltage		$V_{GS}$	±20	V			
Continuous Drain	T <sub>A</sub> =25°C		6.9				
Current <sup>A</sup>	T <sub>A</sub> =70°C	$I_D$	5.8	Α			
Pulsed Drain Current B		I <sub>DM</sub>	30	7			
	T <sub>A</sub> =25°C	$P_{D}$	2	W			
Power Dissipation	T <sub>A</sub> =70°C		1.44	]			
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C			

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s	$R_{\theta JA}$	50	62.5	°C/W			
Maximum Junction-to-Ambient A	Steady-State	IV <sub>θ</sub> JA	82	110	°C/W			
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{ heta JL}$	41	50	°C/W			

#### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units		
STATIC PARAMETERS									
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V			0.004	1	μА		
יטאס	Zero date voltage Brain darrent		T <sub>J</sub> =55°C			5	μΑ		
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V				100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_D=250\mu A$		1	1.8	3	V		
$I_{D(ON)}$	On state drain current	V <sub>GS</sub> =4.5V, V <sub>DS</sub> =5V		20			Α		
	Static Drain-Source On-Resistance	$V_{GS}$ =10V, $I_D$ =6.9A			19	28	mΩ		
$R_{DS(ON)}$			T <sub>J</sub> =125°C		24	30	11152		
		$V_{GS}$ =4.5V, $I_{D}$ =5A			28	42	mΩ		
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =6.9A		10	24		S		
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V			0.77	1	V		
Is	Maximum Body-Diode Continuous Current					4.3	Α		
DYNAMIC	PARAMETERS								
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz			621	820	pF		
Coss	Output Capacitance				118		pF		
$C_{rss}$	Reverse Transfer Capacitance				85		pF		
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz			8.0	1.5	Ω		
SWITCHI	NG PARAMETERS								
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =6.9A			11.3	17	nC		
Q <sub>g</sub> (4.5V)	Total Gate Charge				5.7	8	nC		
$Q_{gs}$	Gate Source Charge				2.1		nC		
$Q_{gd}$	Gate Drain Charge				3		nC		
$t_{D(on)}$	Turn-On DelayTime				4.5	6.5	ns		
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_L$ =2.2 $\Omega$ , $R_{GEN}$ =3 $\Omega$			3.1	5	ns		
t <sub>D(off)</sub>	Turn-Off DelayTime				15.1	23	ns		
t <sub>f</sub>	Turn-Off Fall Time				2.7	5	ns		
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =6.9A, dI/dt=100A/μs			15.5	20	ns		
$Q_{rr}$	Body Diode Reverse Recovery Charge	I <sub>F</sub> =6.9A, dI/dt=100A/μs			7.1	10	nC		

A: The value of  $R_{\theta JA}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.

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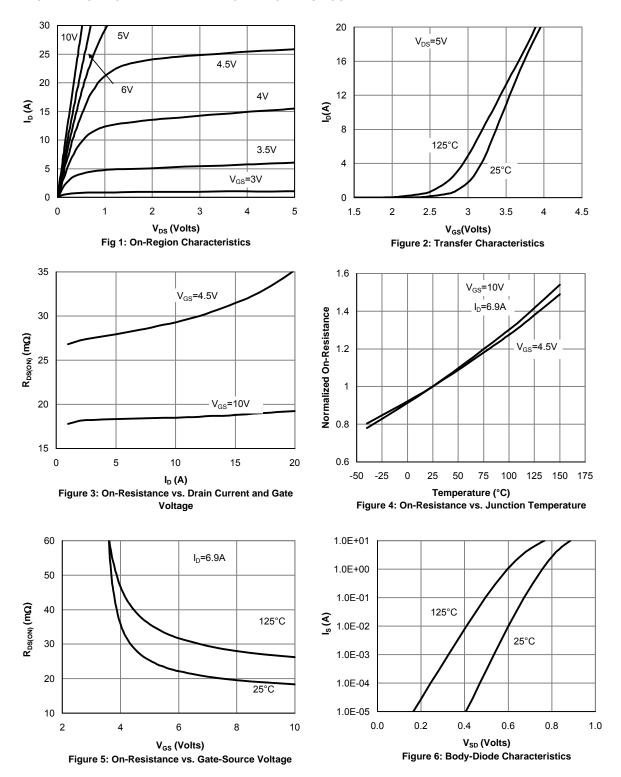
B: Repetitive rating, pulse width limited by junction temperature.

C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R $_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using  $80\mu s$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25°C. The SOA curve provides a single pulse rating.

#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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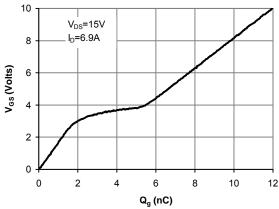


Figure 7: Gate-Charge Characteristics

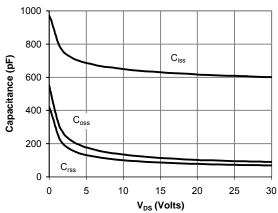


Figure 8: Capacitance Characteristics

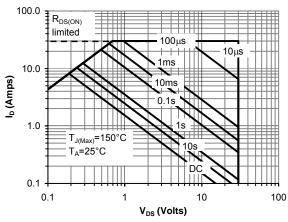


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

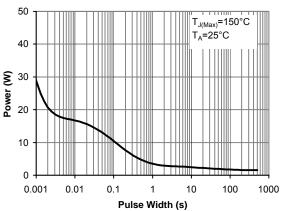


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

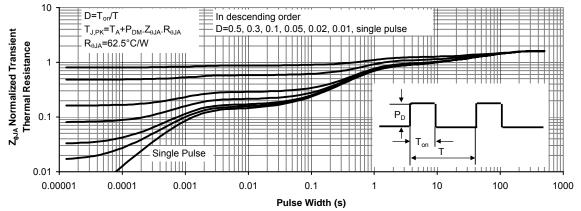


Figure 11: Normalized Maximum Transient Thermal Impedance